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JULY 1991 - REVISED MARCH 1997

- High Current Triacs
- 20 A RMS
- Glass Passivated Wafer
- 400 V to 800 V Off-State Voltage
- 150 A Peak Current
- Max I_{GT} of 50 mA (Quadrants 1 3)

MT1 1 1 2 3 3

Pin 2 is in electrical contact with the mounting base.

MDC2ACA

absolute maximum ratings over operating case temperature (unless otherwise noted)

RATING			VALUE	UNIT
	TIC256D		400	
Repetitive peak off-state voltage (see Note 1)	TIC256M	V	600	V
	TIC256S	V_{DRM}	700	V
	TIC256N	WWW.	800	
Full-cycle RMS on-state current at (or below) 60°C case temperature (see Note 2)			20	Α
Peak on-state surge current full-sine-wave (see Note 3)			150	Α
Peak gate current			±1	Α
Operating case temperature range			-40 to +110	°C
Storage temperature range			-40 to +125	°C
Lead temperature 1.6 mm from case for 10 seconds			230	°C

- NOTES: 1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.
 - 2. This value applies for 50-Hz full-sine-wave operation with resistive load. Above 60°C derate linearly to 110°C case temperature at the rate of 500 mA/°C.
 - 3. This value applies for one 50-Hz full-sine-wave when the device is operating at (or below) the rated value of peak reverse voltage and on-state current. Surge may be repeated after the device has returned to original thermal equilibrium.

electrical characteristics at 25°C case temperature (unless otherwise noted)

	PARAMETER		TEST CONDITI	ONS	MIN	TYP	MAX	UNIT
I _{DRM}	Repetitive peak off-state current	V _D = Rated V _{DRM}	I _G = 0	T _C = 110°C			±2	mA
І _{СТМ}		V _{supply} = +12 V†	$R_L = 10 \Omega$	t _{p(g)} > 20 μs		7	50	mA
	Peak gate trigger	$V_{\text{supply}} = +12 \text{ V}^{\dagger}$	$R_L = 10 \Omega$	t _{p(g)} > 20 μs		-15	-50	
	current	V _{supply} = -12 V†	$R_L = 10 \Omega$	t _{p(g)} > 20 μs		-16	-50	
		V _{supply} = -12 V†	$R_L = 10 \Omega$	t _{p(g)} > 20 μs	-	28		
V _{GTM}		V _{supply} = +12 V†	$R_L = 10 \Omega$	t _{p(g)} > 20 μs		0.7	2	V
	Peak gate trigger	V _{supply} = +12 V†	$R_L = 10 \Omega$	t _{p(g)} > 20 μs	LIVE N	-0.7	-2	
	voltage	$V_{\text{supply}} = -12 \text{ V}^{\dagger}$	$R_L = 10 \Omega$	t _{p(g)} > 20 μs		-0.8	-2	
		V _{supply} = -12 V†	$R_L = 10 \Omega$	t _{p(g)} > 20 μs		0.8	2	
V_{TM}	Peak on-state voltage	I _{TM} = ±28.2 A	$I_G = 50 \text{ mA}$	(see Note 4)		±1.4	±1.7	V
I _H	Holding current	V _{supply} = +12 V†	$I_G = 0$	Init' I _{TM} = 100 mA		6	40	mA
		V _{supply} = -12 V†	$I_G = 0$	Init' $I_{TM} = -100 \text{ mA}$		-13	-40	IIIA

[†] All voltages are with respect to Main Terminal 1.

NOTE 4: This parameter must be measured using pulse techniques, t_p = ≤ 1 ms, duty cycle ≤ 2 %. Voltage-sensing contacts separate from the current carrying contacts are located within 3.2 mm from the device body.





TIC256 SERIES SILICON TRIACS

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electrical characteristics at 25°C case temperature (unless otherwise noted) (continued)

	PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
IL	Latching current	$V_{\text{supply}} = +12 \text{ V}^{\dagger}$ $V_{\text{supply}} = -12 \text{ V}^{\dagger}$	(see Note 5)			20 -20		mA
dv/dt	Critical rate of rise of off-state voltage	V _D = Rated V _D	I _G = 0	T _C = 110°C		±450		V/µs
dv/dt _(c)	Critical rise of commutation voltage	V_D = Rated V_D di/dt = 0.5 $I_{T(RMS)}$ /ms		$T_{C} = 80^{\circ}C$ $I_{T} = 1.4 I_{T(RMS)}$		±1		V/µs
di/dt	Critical rate of rise of on -state current	V_D = Rated V_D di_G/dt = 50 mA/ μ s	I _{GT} = 50 mA	T _C = 110°C		±200		A/µs

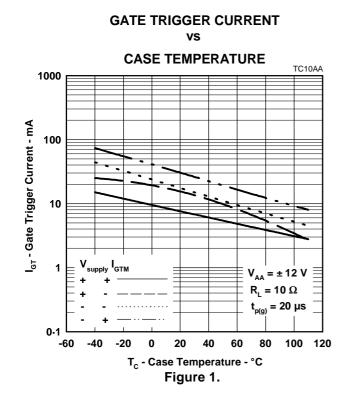
[†] All voltages are with respect to Main Terminal 1.

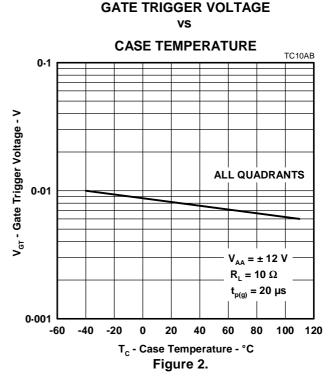
NOTE 5: The triacs are triggered by a 15-V (open-circuit amplitude) pulse supplied by a generator with the following characteristics: $R_G = 100 \ \Omega$, $t_{p(g)} = 20 \ \mu s$, $t_r = \le 15 \ ns$, $f = 1 \ kHz$.

thermal characteristics

PARAMETER			TYP	MAX	UNIT
$R_{\theta JC}$	Junction to case thermal resistance			1.9	°C/W
$R_{\theta JA}$	Junction to free air thermal resistance			62.5	°C/W

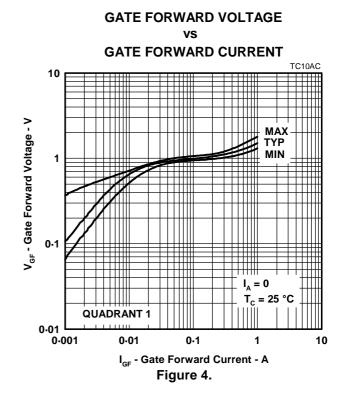
TYPICAL CHARACTERISTICS



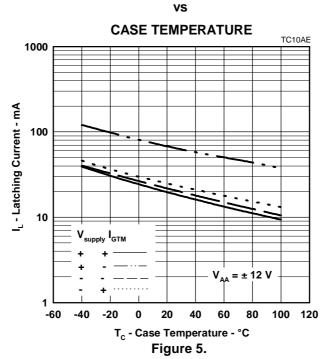


TYPICAL CHARACTERISTICS

HOLDING CURRENT CASE TEMPERATURE TC10AD 100 I_H - Holding Current - mA 10 $I_{\rm G} = 0$ Initiating $I_{TM} = 100 \text{ mA}$ 0.1 20 40 80 100 120 -60 -40 -20 0 T_C - Case Temperature - °C Figure 3.



LATCHING CURRENT



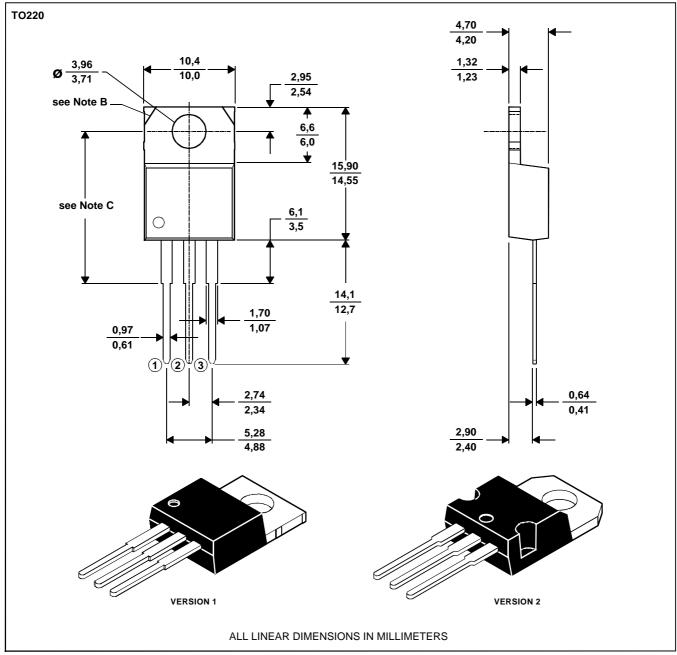


MECHANICAL DATA

TO-220

3-pin plastic flange-mount package

This single-in-line package consists of a circuit mounted on a lead frame and encapsulated within a plastic compound. The compound will withstand soldering temperature with no deformation, and circuit performance characteristics will remain stable when operated in high humidity conditions. Leads require no additional cleaning or processing when used in soldered assembly.



NOTES: A. The centre pin is in electrical contact with the mounting tab.

- B. Mounting tab corner profile according to package version.
- C. Typical fixing hole centre stand off height according to package version. Version 1, 18.0 mm. Version 2, 17.6 mm.

MDXXBE

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